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AlN/ZnO/LiNbO₃ packageless structure as a lowprofile sensor for potential on-body applications

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Abstract— Surface acoustic wave (SAW) sensors find their application in a growing number of fields. This interest stems in particular from their passive nature and the possibility of remote interrogation. Still, the sensor package, due to its size, remains an obstacle for some applications. In this regard, packageless solutions are very promising. This paper describes the potential of the AlN/ZnO/LiNbO3 structure for packageless acoustic wave sensors. This structure, based on the waveguided acoustic wave principle, is studied numerically experimentally. According to the COMSOL simulations, a wave, whose particle displacement is similar to a Rayleigh wave, is confined within the structure when the AlN film is thick enough. This result is confirmed by comprehensive experimental tests, thus proving the potential of this structure for packageless applications, notably temperature sensing.

Index Terms— Surface acoustic wave SAW, temperature sensor, waveguiding layer acoustic wave WLAW, packageless, low-profile.

I. INTRODUCTION

his paper is an extended version of the conference paper [1] presented at the IEEE International Ultrasonics Symposium 2017 in Washington, USA.

Surface Acoustic Wave (SAW) devices are widely used in communication systems as filters or resonators [2]. Thanks to the sensitivity of the resonance frequency to some physical parameters of the environment (for example the temperature), the devices can be also used as sensors. Because SAW sensors can be remotely interrogated (wirelessly) and because they are passive (batteryless), this allows them to be used in a wide range of Radio Frequency (RF) applications [3-7] in various areas, including medicine and sports. Indeed, there is a need for monitoring the data or the parameters of the human body. A limitation to this growing trend remains the presence of the package. The package is useful to protect the device from external perturbations (such as humidity) and for the stress isolation but it is also expensive and bulky. Consequently, the package prevents close contact between the sensor and the target, i.e. the human body. To eliminate this bottleneck, some authors have suggested a bilayer structure with AlN and LiNbO₃ 128° Y-cut [8]. The confinement of the energy is possible due to the use of heavy metal electrodes (Pt) and occurs mostly owing to specific properties of LiNbO₃ 128° Y-cut which shows a decoupling between Rayleigh modes and Shear Horizontal modes. The Waveguiding Layer Acoustic Wave (WLAW) principle is another way to overcome this limitation and to develop a new generation of wireless on-skin sensors [9-11]. In this structure, the acoustic wave is confined in a low velocity film placed inbetween two high velocity materials (see Fig.1). This paper investigates the AlN/ZnO/LiNbO₃ (128° Ycut) structure as a candidate for a WLAW temperature sensor. The ultimate goal is to realize several multifunction sensors and thus to use a reflective delay-line including an ID-Tag. This configuration requires the use of a piezoelectric substrate that has a large electromechanical coupling coefficient (K²) and low propagation losses. Thus, in this work we will try to maximize the K² value of the entire structure. However, for practical considerations, a resonator structure will be considered in this paper. Indeed, the design and manufacturing are easier and the theoretical study can be done considering a single cell of the IDT. This makes the calculations for the structure optimization less time consuming, while enabling the investigation of the wave confinement in this structure, which is the sine qua non feature for packageless applications.

The LiNbO₃ 128° Y-cut was chosen for its high electromechanical coupling coefficient K^2 ($K^2=5.4$ %) and its relatively high acoustic velocity to play the role of the piezoelectric substrate used to generate the acoustic wave [12,13]. The ZnO and the AlN layers are used as a low and a fast velocity layer respectively, in order to build the packageless structure [14-16].

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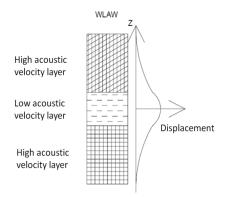


Fig. 1. Principle of the WLAW structure (adapted from [9]). One of the layers needs to be piezoelectric.

II. MATERIALS AND METHODS

A. FEM Modeling

The structure was studied by a 3D-FEM modeling (COMSOL Multiphysics®), using anti-periodic boundary conditions along the X-axis. Physical constants of considered materials were extracted from the literature for AlN and LiNbO₃ [17,18] and by using Comsol Multiphysics® library for ZnO and gold. LiNbO3 is considered as a piezoelectric material to generate the SAW response. AlN and ZnO have also been considered as piezoelectric materials insofar as it has been verified that this feature generates negligible orders of magnitude compared to those due to the elastic constants of the layers. Firstly, only the structure with LiNbO3 and the gold electrodes was calculated and the results were compared to experimental ones. ZnO and AlN layers were then added in the model and their thicknesses were adjusted in order to provide a good electromechanical coupling coefficient (K²). The maximization of the K² value to a certain level is usually appreciable because it reflects the efficiency of conversion between the electrical and the acoustic energy in the piezoelectric material. The minimum AlN thickness required for the wave confinement was finally predicted by the simulations.

B. Experimental part

To yield sensors operating in the 868 MHz ISM band, (Ti 10nm/Au 90nm) SAW devices with a wavelength of 4.4 μm were patterned on the piezoelectric LiNbO₃ 128° Y-cut substrate (MTI Corporation) using e-beam lithography (see Fig.2b and 2c). This synchronous resonator has 100 finger pairs and 200 reflectors on each side. Ion beam etching (IBE) was used to etch the (Ti 10nm/Au 90nm) layers, followed by O₂-plasma treatment to remove the negative resist. Fig.2a, gives a first idea of the future wireless structure. The WLAW structure, based on the resonator configuration, in the center is attached to flexible antennas made of Kapton sheets.

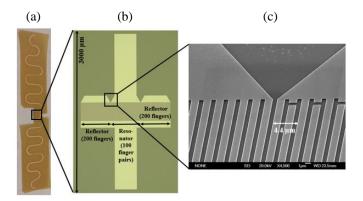


Fig. 2. Top view of finale structure, including the sensor and a flexible antenna (a), and the fabricated SAW device (b and c)

The ZnO and AlN layers were then successively deposited on the top of the electrodes using reactive magnetron sputtering with the following parameters:

> TABLE I SUMMARY OF DEPOSITION PARAMETERS

	ZnO	AlN
Target	ZnO (Ø 4-inch)	Al (Ø 4-inch)
Gases	6 sccm* O ₂	16 sccm* N ₂
	6 sccm* Ar	
Temperature	170°C	No intentional
		heating
Target power	150 W	200 W
Total pressure	6x10 ⁻³ mbar	8x10 ⁻³ mbar

*sccm: standard cubic centimeters per minute (flow unit)

The AlN deposition was performed in several steps with intermediate measurements of the resonator frequency response in order to observe the evolution of the confinement of the wave with respect to the thickness of AlN. To keep the contact with pads for the measurements, a physical shadow masking was used during the deposition steps. SAW devices were characterized using a probe station (Suss Microtech PM5) and a network analyzer (VNA Agilent-N5230A). The probe station is equipped with a thermal chuck allowing the control of the temperature between 20 and 100°C with a precision of 0.1°C.

In order to verify experimentally the confinement of the wave in the WLAW device, we investigated the effect of addition of a soft elastomeric matter on top of it: if no change in the S-parameters is observed, then it proves that the wave is confined (see Fig.3).

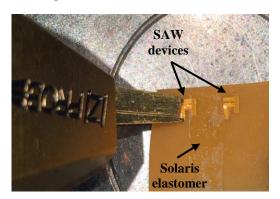


Fig. 3. Measurement of S-parameters with the silicone elastomer Solaris on top of the device after ZnO and AlN depositions.

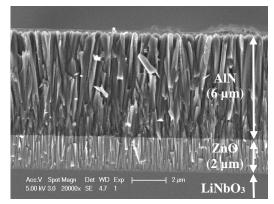


Fig. 4. SEM cross-sectional image of the AlN/ZnO/LiNbO₃ structure.

To remain as close as possible to the intended application, an absorber with almost the same properties as the skin such as the Solaris elastomer (Smooth-on, USA, E_{Young}=172 kPa) has been chosen. Finally, scanning electron microscopy (SEM) was used to check the thickness of the deposited films (see Fig.4).

III. RESULTS

A. FEM Modeling

Initial calculations were performed using a top and a bottom layer with a thickness large enough to ensure the confinement of the wave on each side. In this configuration it has thus been found that 2 µm provides a good value for the ZnO layer thickness. Indeed, with this thickness, the K² value remains high enough (more than 4%) to achieve future reflective delaylines while the wave propagation is mainly confined around the ZnO/LiNbO3 interface. Moreover, we show that the required thickness of AlN to ensure the wave isolation is limited to several microns. The model used for the resonator description will serve as a basis for the delay-lines modeling and design, after experimental verification and parameters extraction.

The numerical criterion we used to assess the wave confinement is the following: a wave is considered confined when the surface displacement is less than 1% of the waves' maximum displacement.

With the fixed value of 2 μm of ZnO, 7.5 μm of AlN, or more, are required to fully confine all the waves between 580 and 1100 MHz. Focusing on the wave at 837 MHz, the simulations even predicts that an AlN thickness of 5 μm is sufficient to confine this particular wave. In order to maintain a security margin for the manufacturing process, the value of 6 μm has been selected.

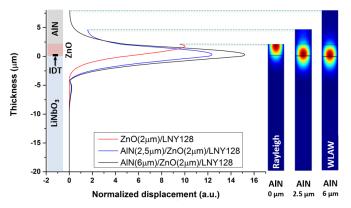


Fig. 5. Total particle displacement evolution as a function of the AlN thickness (1D display on the left, 2D on the right).

Fig.5 shows, for three different AlN thicknesses, the particle displacement along the Z-axis (normal to the surface structure) when a voltage is applied on the Inter-Digital Transducers (IDTs). Compared to the cases with 0 or 2.5 μm of AlN, the displacement at the surface of the structure is much more limited when the AlN thickness is 6 μm (less than 1% of the maximum displacement).

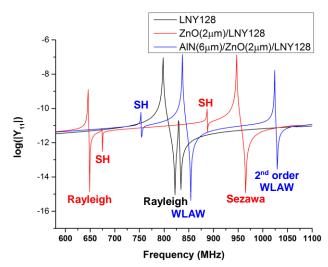


Fig. 6. Theoretical evolution of the admittance Y_{11} magnitude as a function of the frequency, for different configurations.

Fig.6 depicts the evolution of the calculated admittance magnitude for the different structures, as well as the identified modes. This figure also highlights the frequency shifts due to the presence of additional layers.

From the 3D simulations, 2D projections of the displacements in the X, Y and Z directions were created to identify those different waves (Table II). It was also possible to track the evolution of each mode when layers of different thicknesses were added to the model.

Table II shows some of those modes: Rayleigh modes are characterized by the absence of Y displacement and a large Z displacement, whereas Shear Horizontal (SH) modes display large Y displacement. For growing AlN thicknesses (6 μ m), we observe a confined wave with a displacement similar to a Rayleigh wave (noted WLAW), as well as a confined SH-type wave.

B. Impedance measurements and discussion

Impedance measurements confirm the change in frequency due to additional layers. LiNbO $_3$ is characterized as a material with a high propagation velocity with respect to ZnO [12,13]. Therefore, the ZnO/LiNbO $_3$ bilayer structure shows lower acoustic velocities than those of the substrate alone, and thus

lower operating frequencies as shown by the impedance measurements (see Fig.7). The AlN layer has also a high propagation velocity [14], so according to the same principle, the average velocity of the AlN/ZnO/LiNbO₃ structure is higher than that of the ZnO/LiNbO₃ bilayer structure.

TABLE II: NUMERICAL EVALUATION OF THE PARTICLE DISPLACEMENT IN THE STRUCTURE FOR SOME RELEVANT MODES

Structure Wave type	Total displacement	Displacement along X-axis	Displacement along Y-axis	Displacement along Z-axis
ZnO(2µm)/LNY128 Rayleigh wave at 643 MH z	V Tx			
AlN(2.5μm)/ZnO(2μm)/LNY128 Similar to a Rayleigh wave at 8 35 MH z	v.t.x			•
AlN(6μm)/ZnO(2μm)/LNY128 Similar to a Rayleigh wave at 837 MHz (WLAW)	y tx			•
AlN(6μm)/ZnO(2μm)/LNY128 Similar to a SH wave at 753 MH z	v t x			

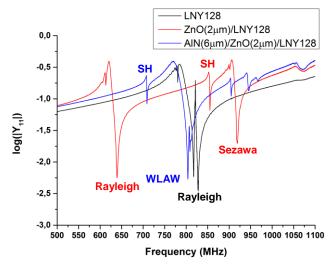


Fig. 7. Evolution of the measured admittance Y₁₁ magnitude as a function of the frequency, for different configurations.

The K² values can be evaluated with the approximation:

$$K^2 = \frac{2(f_r - f_a)}{f_r}$$

where f_r and f_a are the resonance and anti-resonance frequencies, respectively extracted from Fig.6 or 7. In the theoretical case the estimated value is around 4%. In the experimental case, it is unfortunately difficult to determine the f_r value for the K^2 calculation. The K^2 approximation with a rough value for f_r is nevertheless promising because greater than 6%. Future achievements are needed to confirm this value and to explain the difference with the theoretical value.

Fig.8, shows the measured conductance of the resonator (G=Real(Y)) versus the frequency of the AlN/ZnO/LiNbO₃ structure. The experimental value of the Q factor is estimated by the inverse of fractional bandwidth between frequencies where the conductance value becomes the half of the peak [19]. The unloaded Q-factor achieved is close to 450 which is low to ensure a high sensitivity needed for a wireless sensor. This low value is in part due to the quality of the polycrystalline ZnO thin film that should be improved. Still, to allow wireless measurement, not only the Q value is important, but also the K^2 . Indeed, following [20] the efficiency of energy re-radiation requires that the product $Q \cdot K_C$ be over 4, where $K_C = C_S/C$, C being the motional capacitance and C_S being the static capacitance in the resonator equivalent circuit; their ratio strongly depends on K^2 .

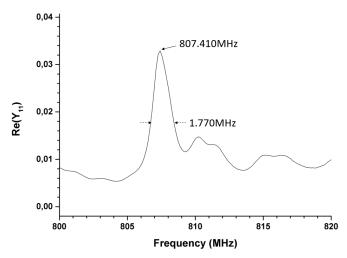


Fig. 8. Measured resonator conductance versus the frequency.

In addition, tests with the silicone-based Solaris elastomer (see II.B) were carried out to prove the wave confinement. For practical purposes, devices with longer access pads were used as shown in Fig.3. Indeed, without AlN top layer, the Solaris slab, placed on top of the structure disturbs the S_{11} signal (see Fig.9, top). On the opposite, in the structure with 6 µm of AlN, the wave at 790 MHz do not experience any change in impedance when the absorber is placed on top of it. This proves the confinement for this particular wave, noted WLAW (see Fig.9, middle). To push the analysis further, it can be noticed that the wave around 950 MHz is still disturbed by the Solaris elastomer in this configuration. This higher order mode is only confined with a thicker AlN film, e.g. with 8 µm of AlN no more changes occur (see Fig.9, bottom). In conclusion, the proposed structure is validated for packageless applications. The ZnO and AlN layers act as a package and protect the wave from external perturbations such as moisture.

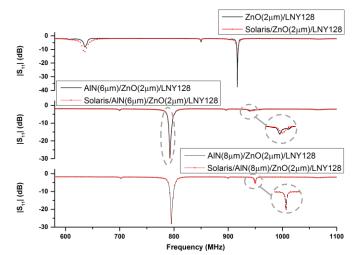


Fig. 9. Experimental evolution of the S_{11} magnitude as a function of frequency.

The structure with 6 μ m of AlN, where only the WLAW wave at 790 MHz is confined, is still of interest because it could be used as a compensated sensor. On the one hand, the isolated wave is independent of the surface perturbation and can therefore be used as a reference, for example as a temperature

sensor. On the other hand, the non-isolated wave is sensitive to a perturbation on the surface and can thus serve as a gas or humidity sensor while removing the temperature influence.

C. Temperature sensing potential of the structure

The temperature coefficient of frequency (TCF) of some modes was determined from the evolution of the operating frequency as a function of temperature (see Fig.10). The TCF is calculated using the equation:

$$TCF = \frac{1}{f_0} \frac{\Delta f}{\Delta T}$$

where f_0 is the operating frequency of the device at room temperature.

TCF measurements show, as expected from the literature [13], a value of -78 ppm/°C when only the substrate (LiNbO $_3$ 128° Y-cut) and the gold IDTs are measured. For the WLAW structure AlN(6 μ m)/ZnO(2 μ m)/LiNbO $_3$, a noticeably high value of -106 ppm/°C was measured. Thus, a high sensitivity is expected for temperature sensors based on the WLAW structure. Indeed, for devices operating in the 868 MHz ISM band and assuming that the electronic reader has a detection limit of 10 kHz, the sensor precision is expected to be around 0.1°C.

The frequency shift in the S₁₁ curves due to the temperature increase illustrate the experimental method used (see Fig.11). From those measurements we also extracted the TCF of the first peak corresponding to SH wave around 700 MHz and to those of the higher modes recorded around 900 and 950 MHz. Their respective TCF values are: -90.8; -92.4 and -102.3 ppm/°C.

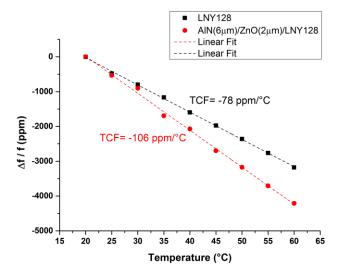


Fig. 10. Relative frequency shifts with respect to the temperature.

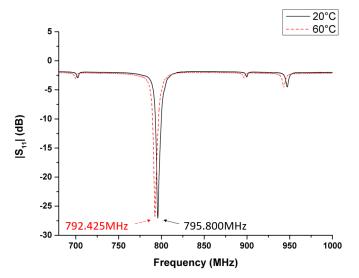


Fig. 11. Experimental S₁₁ signal measurements at 20 and 60°C.

IV. CONCLUSION AND PERSPECTIVES

The numerical and experimental measurements have allowed to obtain a better understanding of the $AlN/ZnO/LiNbO_3$ (128° Y-cut) acoustic waves structure: the different modes and the changes in velocities (and thus in the resonance frequencies) with each layer addition as a function of the relative hardnesses.

Impedance measurements, insensitive to the presence of an elastomeric absorber, led to the demonstration of the confinement of a WLAW wave, in the configuration with 2 μ m of ZnO and 6 μ m of AlN.

This result is in agreement with the COMSOL simulations that predicted a sufficient value of 5 μm (or 6 μm with some reasonable margin) of AlN to observe the confinement of the WLAW wave.

Hence, the $AlN/ZnO/LiNbO_3$ (128° Y-cut) structure has been validated for packageless applications. Moreover, TCF measurements show promises for on-body temperature sensing applications.

As a short term perspective, the aim is to improve the quality factor Q of the devices, which requires to reduce the acoustic losses. In the present case the wave propagation takes place mainly in the ZnO layer which has been deposited by magnetron sputtering. By forcing the wave to propagate in the single crystal lithium niobate substrate rather than in the ZnO layer, losses can be reduced. Diamond, which is harder than AlN may then be considered for the upper layer [21]. Comparison between the two structures AlN/ZnO/LiNbO₃ and Diamond/ZnO/LiNbO₃ are in progress [22]. In order to obtain low-profile sensors, the manufacturing of SAW devices on thinned substrates is also interesting.

Additionally, the manufacturing of flexible antennas will be performed in order to yield complete wireless sensors based on the WLAW structure. The final sensor will be fixed on the human body for temperature measurements, and the elastic property of the antennas will compensate the strain due to the skin deformation. For the first experiment, antennas were made with Kapton sheets with a thickness of 25 μ m. Fig.2a gives an

overview of the final structure where the $AlN/ZnO/LiNbO_3$ (128° Y-cut) WLAW structure is placed in the center and fixed to the antennas.

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Sergei Zhgoon (A'96–M'96–SM'09) graduated from Moscow Power Engineering Institute (MPEI) in 1974 (present name: National Research University MPEI). He received his Ph.D. degree from the same university in 1979. In 1986, he was awarded the degree of Senior Research Fellow.

Since 1974 he has been permanently working at the Department of Radio Engineering Fundamentals in MPEI. Since 1983 he has been the head of the laboratory in this department. His present research interests are in surface acoustic wave (SAW) devices since 1975. His main areas of expertise presently include all aspect of microwave acoustics device fundamentals, design of SAW/BAW filters, resonators, RF ID tags and their preparation techniques, thin film deposition and patterning, advanced chip-scale and wafer-scale packaging with MEMS-like techniques, surface acoustic wave propagation in

multilayered and strained media, and SAW sensors based on these phenomena. He has co-authored over 190 publications and about 20 patents. He has supervised over 20 M.S. and 4 Ph.D. students in MPEI.



Mohammed Moutaouekkil started his Ph.D. with the University of Mohammed 1, Oujda, Morocco. He is currently research teaching associate at the Institut Jean Lamour, Nancy, France, and is working on SAW devices. He has gained great experience in numerical simulation in phononic crystals for biosensor

applications and magnetoacoustics for magnetic sensor.



Florian Bartoli was born in Viéville-en-Haye, France, in 1989. He received his Master's degree in theoretical physics, optics and photonics sciences, from the University of Lorraine in 2015. The same year, he started his Ph.D. in the CentraleSupélec engineering school and joined the Laboratoire Matériaux Optiques,

Photonique et Systèmes (LMOPS) and the Institut Jean Lamour labs. The aim of his current work is to achieve a packageless SAW device working at high temperature.



Harshad Mishra was born in 1989 in the province of Odisha in India. He graduated with a Master of Science (by Research) degree from the Indian Institute of Technology Madras in Chennai, India in the year 2016. There he worked on development of magnetostrictive thin films for actuator applications. He joined the

Micro-nanosystems group at the Institut Jean Lamour in 2017 as a Ph.D. student. His current research is focused on development and optimization of SAW based resonators for magnetic field sensing applications.



Stefan Mc Murtry is part of the Micronanosystems group of the Institut Jean Lamour (IJL) and is research engineer at CNRS (Centre National pour la Recherche Scientifique). After his Ph.D. in optical fibre optics multiplexing in UK, he was involved in two European project (Falcon, ISIS) at IEMN in France (Institut

d'Electronique de Microelectronique et de Nanotechnologie) and collaborated with several industrials (Thales, Sagem, ESA ...) on the topic of nanofabrication. His current research at IJL includes the nanofabrication and use of nanocapsules in the healthcare sector (Patent WO2013186292A2) and is the author and co-author of 3 patents and over 25 publications.



Philippe Pigeat was born in 1953. He obtained his engineering degree at ENSEM, Nancy, France, in 1977 and his Ph.D. degree in 1986 for his work on fluctuations in the thermal emission of tungsten during its oxidation process. Since then he is research scientist at the CNRS (Centre National pour la Recherche Scientifique). He works in

particular on the physical vapor deposition (PVD) of AlN thin films doped with rare-earth materials and on their structural and in situ optical characterization.



Thierry Aubert was born in Epinal, France, in 1975. In 1999, he passed the "Agrégation de Physique", a French national highly competitive exam. Then, he received the M.Sc. degree in Physics and the Ph.D. degree from the University of Nancy I, France, in 2007, and 2010 respectively. His Ph.D. thesis work was

focused on the choice of materials for high temperature SAW applications. He studied in particular the possibility to use AlN/Sapphire bilayer structure for such aim. Between November 2010 and July 2011, he was with the CTR, Villach, Austria, where he obtained new results by achieving in situ electrical characterization of langasite and AlN-based SAW devices in high-temperature environment, up to temperatures above 1100°C. He then has been an Associate Professor with the Université de Savoie, Annecy, France. Since September 2014, he is with CentraleSupélec, an internationally-reputed French Higher Education and Research Institution, in the LMOPS laboratory (Metz, France), of which he is deputy director since March 2017. His research activities are focused on the investigation of new materials and structures for hightemperature SAW applications (WLAW structures, Ir/Rh thin film electrodes, piezoelectric ScAlN thin films stoichiometric lithium niobate crystals).



Olivier Bou Matar was born in Villeneuve-sur-Lot, France, in 1970. He received the Ph.D. degree in acoustics from the University of Tours, Tours, France, in 1997. He joined the Blois Technological Institute, Blois, as an Associate Professor of Electronic and Communication Systems in 1998. Since 2005, he has been a Full

Professor with the École Centrale de Lille, Villeneuve-d'Ascq, France. He is currently with the Magnetoacoustics Research Institut d'Electronique, Microelectronique Nanotechnologies. He is involved with the Joint International Franco-Russian-Ukrainian Laboratory. He has gained great experience in numerical simulation of nonlinear acoustic wave propagation, in the development of ultrasonic imaging systems (nonlinear imaging by magneto-acoustic phase conjugation), and in multiphysics applications involving wave propagation in solids and liquids. He is also the Head of the Acoustical Department with the Institut d'Electronique, Microelectronique et Nanotechnologies, Villeneuve d'Ascq. He has co-authored over 120 international publications in journals and proceedings mainly in the domain of nonlinear acoustic, phononic crystals,

and magnetoacoustic. His current research interests include nonlinear magnetoelasticity and magnetostrictive films for microsystems.



Abdelkrim Talbi received the M.S. degree in plasma, optics, electronics, and microsystems from the University of Metz, Metz, France, University of Nancy I, Nancy, France, and SupElec Metz, Metz, France, in 2000, and the Ph.D. degree from the University of Nancy I, Nancy, France, in 2003. He is an Associate Professor with

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Omar Elmazria (M'2001–SM'16) received his Ph.D. degree in electronics from Metz University, France, in 1996 and he joined the University of Nancy I as associate Professor of electronic and communication systems in 1997 and as a full Professor in 2003. He was the Head of the Micro-nanosystems group within the

Institut Jean Lamour. His current research focus on layered structures based surface acoustic waves (SAW) devices for communication systems and sensing applications. He coauthored more than 150 papers in refereed international journals and in proceeding of international conferences. In 2017, he received the medal of URSI-France (International Union of Radio Science).